

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANTS PTO FORM 1449</b>	Atty. Docket No. 2207/10551	Serial No. To Be Assigned
	Applicant(s) Samaan et al.	
	Filing Date Herewith	Group To Be Assigned

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#### U. S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE
TN	6,075,908	Jun. 13, 2000	Paniccia et al.	—	—	
TN	6,111,424	Aug. 29, 2000	Bosacchi	—	—	

#### FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	NO

#### OTHER DOCUMENTS

EXAMINER'S INITIALS		AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
TN	1	Hungerford et al., <i>Single-photon Timing Detectors For Fluorescence Lifetime Spectroscopy</i> , Univ. of Strathclyde, Dept of Physics and Applied Physics, 1995, pgs. 121-136.
	1	Kash et al., <i>Hot Luminescence From CMOS Circuits: A Picosecond Probe of Internal Timing</i> , IBM Research Division, New York, Nov. 1997, vol. 204, No. 1, pgs 507-16.
	1	Simon M.Sze, <i>Physics of Semiconductor Devices</i> , 2 <sup>nd</sup> ed., Wiley, John & Sons, Inc., Jan. 1991, pg. 439.
	1	Tsang et al., <i>Picosecond Hot Electron Light Emission From Submicron Complementary Metal-Oxide-Semiconductor Circuits</i> , Applied Physics Letters, Vol. 70, No. 7, Feb. 1997, pgs. 889-91.
TN	1	Tsang et al., <i>Picosecond Imaging Circuit Analysis</i> , IBM J. Res. Develop., Vol. 44, No. 4, July 2000, pgs. 583-603.

EXAMINER <i>Timmy Nguyen</i>	DATE CONSIDERED <i>3/5/03</i>
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	